

Test Report

Report No.: MTi230621016-04E2

Date of issue: 2023-07-17

Applicant: Shenzhen Baseus Technology Co., Ltd.

Product: Baseus Neckband Wireless Earphones

Model(s): Baseus Bowie P1 2023

FCC ID: 2A482-XP1

Shenzhen Microtest Co., Ltd.

http://www.mtitest.com



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- 5. Any objection to this test report shall be submitted to the laboratory within 15 days from the date of receipt of the report.

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Test Result Certification				
Applicant:	Shenzhen Baseus Technology Co., Ltd.			
Address:	2nd Floor, Building B, Baseus Intelligence Park, No.2008, Xuegang Rd, Gangtou Community, Bantian Street, Longgang District, Shenzhen.			
Manufacturer:	Shenzhen Baseus Technology Co., Ltd.			
Address:	2nd Floor, Building B, Baseus Intelligence Park, No.2008, Xuegang Rd, Gangtou Community, Bantian Street, Longgang District, Shenzhen.			
Product description				
Product name:	Baseus Neckband Wireless Earphones			
Trademark:	baseus			
Model name:	Baseus Bowie P1 2023			
Series Model:	N/A			
Standards:	47 CFR Part 15.247			
Test Standards:	ANSI C63.10 KDB 558074 D01 D15.247 Meas Guidance v05r02			
Date of Test				
Date of test:	2023-06-29 to 2023-07-14			
Test result:	Pass			

Test Engineer :	:	Yanice Xie
		(Yanice.Xie)
Reviewed By :		leon chen
		(Leon Chen)
Approved By :	:	Tom Xue
		(Tom Xue)



1 General Description

1.1 Description of the EUT

Product name:	Baseus Neckband Wireless Earphones			
Model name:	Baseus Bowie P1 2023			
Series Model:	N/A			
Model difference:	N/A			
Electrical rating:	Input: DC 5V 120mA Battery: DC 3.7V 170mAh 0.629Wh			
Accessories:	Cable: USC-A to Type-C 0.3m			
Hardware version:	Bowie_P1_BK3296_V1.0			
Software version:	(Baseus Bowie P1)_1.5.06			
Test sample(s) number:	MTi230621016-04S1001			
RF specification				
Bluetooth version:	V5.2			
Operating frequency range:	2402-2480			
Channel number:	79			
Modulation type:	GFSK, π/4-DQPSK, 8DPSK			
Antenna(s) type:	Chip Antenna			
Antenna(s) gain:	2.67 dBi			
10. Description of the translation				

1.2 Description of test modes

All the test modes were carried out with the EUT in normal operation, the final test mode of the EUT was the worst test mode for emission test, which was shown in this report and defined as:

No.	Emission test modes
Mode1	TX- GFSK(CH00, CH39, CH78)
Mode2	TX-π/4-DQPSK (CH00, CH39, CH78)
Mode3	TX- 8DPSK (CH00, CH39, CH78)



1.3 Description of test modes

1.3.1 Operation channel list

Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461	-	-

Note: The test software provided by manufacturer is used to control EUT for working in engineering mode, that enables selectable channel, and capable of continuous transmitting mode.

Mada	Test Software	BK32xx RF Test_V1.8.2			
Mode	Channel	2402MHz	2441MHz	2480MHz	
GFSK		3	3	3	
π/4-DQPSK	Power setting	3	3	3	
8DPSK		3	3	3	

Test Software:





1.4 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15°C ~ 35°C
Humidity:	20% RH ~ 75% RH
Atmospheric pressure:	98 kPa ~ 101 kPa

1.5 Description of support units

Support equipment list						
Description Model Serial No. Manufacturer						
/	1	/	/			
Support cable list						
Description	Length (m)	From	То			
1	1	1	/			

1.6 Measurement uncertainty

Measurement	Uncertainty
Occupied channel bandwidth	±3 %
RF output power, conducted	±1 dB
Time	±1 %
Unwanted Emissions, conducted	±1 dB
Radiated spurious emissions (1GHz~25GHz)	5.3dB
Radiated spurious emissions (9kHz~30MHz)	4.3dB
Radiated spurious emissions (30MHz~1GHz)	4.7dB
Temperature	±1 °C
Humidity	± 5 %

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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2 Summary of Test Result

No.	FCC reference	Description of test	Result
1	§ 15.203	Antenna requirement	Pass
2	§ 15.207	AC power line conducted emissions	N/A
3	§ 15.247(d), 15.209, 15.205	Radiated spurious emissions	Pass
4	§ 15.247(a)(1)	20dB emission bandwidth	Pass
5	§ 15.247(b)(1)	Maximum conducted output power	Pass
6	§ 15.247(a)(1)	Carrier Frequencies Separation	Pass
7	§ 15.247(a)(1)	Time of occupancy	Pass
8	§ 15.247(a)(1)	Number of hopping channels	Pass
9	§ 15.247(d)	Band edge (Conducted)	Pass
10	§ 15.247(d)	Conducted spurious emissions	Pass

Notes:

N/A means not applicable.

Since the EUT cannot be operating while charging, therefore AC power line conducted emissions test is not required



3 Test Facilities and accreditations

3.1 Test laboratory

Test laboratory:	Shenzhen Microtest Co., Ltd.
Test site location:	101, No.7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China
Telephone:	(86-755)88850135
Fax:	(86-755)88850136
CNAS Registration No.:	CNAS L5868
FCC Registration No.:	448573



4 List of test equipment

No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due		
	Occupied Bandwidth							
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
		Maximum Co	nducted Output	Power	1			
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
		Chan	nel Separation					
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		



No. **Equipment** Manufacturer Model Serial No. Cal. date Cal. Due 9 DC Power Supply Agilent E3632A MY40027695 2023-05-05 2024-05-04 Number of Hopping Frequencies Wideband Radio 1 Rohde&schwarz CMW500 149155 2023-04-26 2024-04-25 **Communication Tester ESG Series Analog** 2 Agilent E4421B GB40051240 2023-04-25 2024-04-24 Ssignal Generator 3 PXA Signal Analyzer N9030A MY51350296 2023-04-25 2024-04-24 Agilent 4 Synthesized Sweeper 83752A 3610A01957 2023-04-25 2024-04-24 Agilent 5 N9020A MY50143483 2023-04-26 2024-04-25 MXA Signal Analyzer Agilent 6 RF Control Unit Tonscend JS0806-1 19D8060152 2023-04-26 2024-04-25 7 Tonscend Band Reject Filter Group JS0806-F 19D8060160 2023-05-05 2024-05-04 **ESG Vector Signal** MY50143762 8 2023-04-25 2024-04-24 N5182A Agilent Generator 9 DC Power Supply Agilent E3632A MY40027695 2023-05-05 2024-05-04 **Dwell Time** Wideband Radio 1 CMW500 149155 2023-04-26 2024-04-25 Rohde&schwarz **Communication Tester ESG Series Analog** 2 E4421B GB40051240 2023-04-25 2024-04-24 Agilent Ssignal Generator 3 PXA Signal Analyzer Agilent N9030A MY51350296 2023-04-25 2024-04-24 4 Synthesized Sweeper 83752A 3610A01957 2023-04-25 2024-04-24 Agilent N9020A MY50143483 2023-04-26 2024-04-25 5 MXA Signal Analyzer Agilent 6 2023-04-26 2024-04-25 RF Control Unit Tonscend JS0806-1 19D8060152 7 Band Reject Filter Group Tonscend JS0806-F 19D8060160 2023-05-05 2024-05-04 **ESG Vector Signal** 8 2024-04-24 Agilent N5182A MY50143762 2023-04-25 Generator 9 DC Power Supply E3632A MY40027695 2023-05-05 2024-05-04 Agilent Emissions in non-restricted frequency bands Wideband Radio Rohde&schwarz CMW500 2023-04-26 2024-04-25 1 149155 **Communication Tester ESG Series Analog** 2 GB40051240 Agilent E4421B 2023-04-25 2024-04-24 Ssignal Generator 3 PXA Signal Analyzer Agilent N9030A MY51350296 2023-04-25 2024-04-24 4 Synthesized Sweeper 83752A 3610A01957 2023-04-25 2024-04-24 Agilent 5 N9020A MY50143483 2023-04-26 2024-04-25 MXA Signal Analyzer Agilent 6 RF Control Unit Tonscend JS0806-1 19D8060152 2023-04-26 2024-04-25 7 JS0806-F 2023-05-05 2024-05-04 Band Reject Filter Group Tonscend 19D8060160 **ESG Vector Signal** 8 N5182A MY50143762 2023-04-25 2024-04-24 Agilent Generator



No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
	Band edge emissions (Radiated)							
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25		
2	Double Ridged Broadband Horn Antenna	schwarabeck	BBHA 9120 D	2278	2023-05-26	2024-05-25		
3	Amplifier	Agilent	8449B	3008A01120	2023-05-26	2024-05-25		
4	Multi-device Controller	TuoPu	TPMDC	1	1	1		
5	MXA signal analyzer	Agilent	N9020A	MY54440859	2023-05-05	2024-05-04		
	Emissions in restricted frequency bands (below 1GHz)							
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25		
2	TRILOG Broadband Antenna	schwarabeck	VULB 9163	9163-1338	2023-06-11	2025-06-10		
3	Amplifier	Hewlett-Packard	8447F	3113A06184	2023-04-26	2024-04-25		
4	Multi-device Controller	TuoPu	TPMDC	1	1	1		
	Em	issions in restricted	frequency band	ls (above 1GHz)				
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25		
2	Double Ridged Broadband Horn Antenna	schwarabeck	BBHA 9120 D	2278	2023-05-26	2024-05-25		
3	Amplifier	Agilent	8449B	3008A01120	2023-05-26	2024-05-25		
4	Multi-device Controller TuoPu		TPMDC	1	/	1		
5	MXA signal analyzer	Agilent	N9020A	MY54440859	2023-05-05	2024-05-04		



5 Evaluation Results (Evaluation)

5.1 Antenna requirement

Test Requirement:	An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.
Description of the antenna of EUT:	The antenna of the EUT is permanently attached.
Conclusion:	The EUT complies with the requirement of FCC PART 15.203.

6 Radio Spectrum Matter Test Results (RF)

6.1 Occupied Bandwidth

Test Requirement:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Limit:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method:	Occupied bandwidth—relative measurement procedure
Procedure:	a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2. d) Steps a) through c) might require iteration to adjust within the specified tolerances. e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the -20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the reference value. f) Set detection mode to peak and trace mode to max hold. g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value). h) Determine the "-xx dB down amplitude" using [(reference value) - xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument.

i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j).

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- j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the "-xx dB down amplitude" determined in step h). If a marker is below this "-xx dB down amplitude" value, then it shall be as close as possible to this value. The occupied bandwidth is the frequency difference between the two markers. Alternatively, set a marker at the lowest frequency of the envelope of the spectral display, such that the marker is at or slightly below the "-xx dB down amplitude" determined in step h). Reset the marker-delta function and move the marker to the other side of the emission until the delta marker amplitude is at the same level as the reference marker amplitude. The marker-delta frequency reading at this point is the specified emission bandwidth.
- k) The occupied bandwidth shall be reported by providing plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

6.1.1 E.U.T. Operation:

Operating Envi	Operating Environment:						
Temperature:	26 °C		Humidity:	57 %		Atmospheric Pressure:	101 kPa
Pre test mode:		Mode	e1, Mode2,	Mode3			
Final test mode: Mod		Mode	e1, Mode2,	Mode3	•		

6.1.2 Test Data:

Please Refer to Appendix for Details.



6.2 Maximum Conducted Output Power

Test Requirement:	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Limit:	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method:	Output power test procedure for frequency-hopping spread-spectrum (FHSS) devices
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test: a) Use the following spectrum analyzer settings: 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. 2) RBW > 20 dB bandwidth of the emission being measured. 3) VBW >= RBW. 4) Sweep: Auto. 5) Detector function: Peak. 6) Trace: Max hold. b) Allow trace to stabilize. c) Use the marker-to-peak function to set the marker to the peak of the emission. d) The indicated level is the peak output power, after any corrections for external attenuators and cables. e) A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

6.2.1 E.U.T. Operation:

Operating Environment:					
Temperature: 26 °C	Humidity	57 %	Atmospheric Pressure:	101 kPa	
Pre test mode:	Mode1, Mode2	, Mode3			
Final test mode:	Mode1, Mode2	, Mode3			

6.2.2 Test Data:

Please Refer to Appendix for Details.



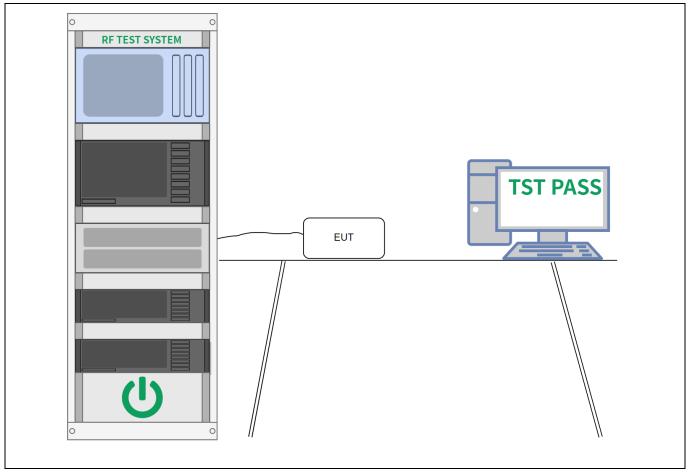
6.3 Channel Separation

Test Requirement:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Limit:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	Carrier frequency separation
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.
	c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: Auto.
	e) Detector function: Peak. f) Trace: Max hold.
	g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report.

6.3.1 E.U.T. Operation:

Operating Envi	Operating Environment:						
Temperature:	26 °C		Humidity:	57 %		Atmospheric Pressure:	101 kPa
Pre test mode:		Mode	e1, Mode2,	Mode3			
Final test mode:		Mode	e1, Mode2, I	Mode3			

6.3.2 Test Setup Diagram:



6.3.3 Test Data:

Please Refer to Appendix for Details.



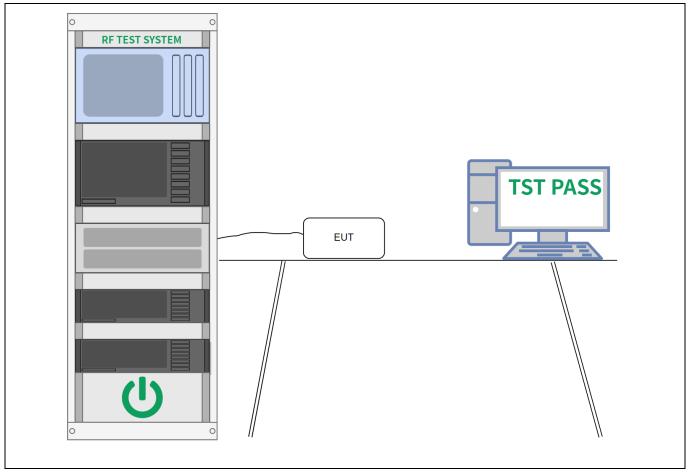
6.4 Number of Hopping Frequencies

	· · · · · · · · · · · · · · · · · · ·
Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Number of hopping frequencies
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.

6.4.1 E.U.T. Operation:

Operating Envi	Operating Environment:						
Temperature:	26 °C		Humidity:	57 %		Atmospheric Pressure:	101 kPa
Pre test mode:		Mode	e1, Mode2,	Mode3			
Final test mode:		Mode	e1, Mode2, I	Mode3			

6.4.2 Test Setup Diagram:



6.4.3 Test Data:

Please Refer to Appendix for Details.



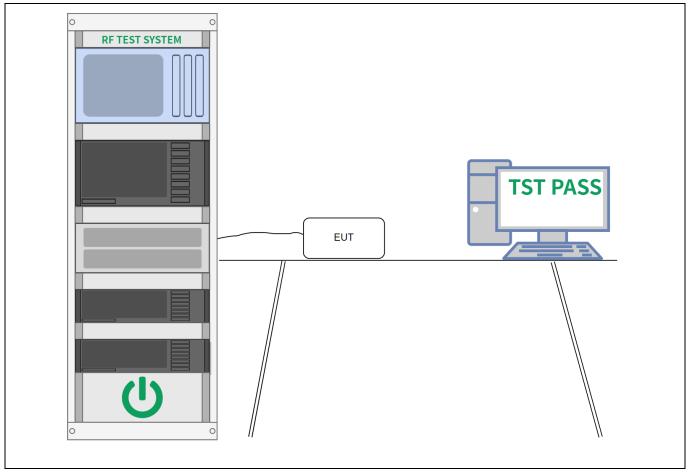
6.5 Dwell Time

6.5 Dwell time	
Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Time of occupancy (dwell time)
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements) = (number of hops on spectrum analyzer) × (period specified in the
	requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the values described in the operational description for the EUT.

6.5.1 E.U.T. Operation:

Operating Environme	Operating Environment:						
Temperature: 26 °C		Humidity:	57 %	Atmospheric Pressure:	101 kPa		
Pre test mode:	Mod	e1, Mode2,	Mode3				
Final test mode:	Mod	e1, Mode2,	Mode3				

6.5.2 Test Setup Diagram:



6.5.3 Test Data:

Please Refer to Appendix for Details.



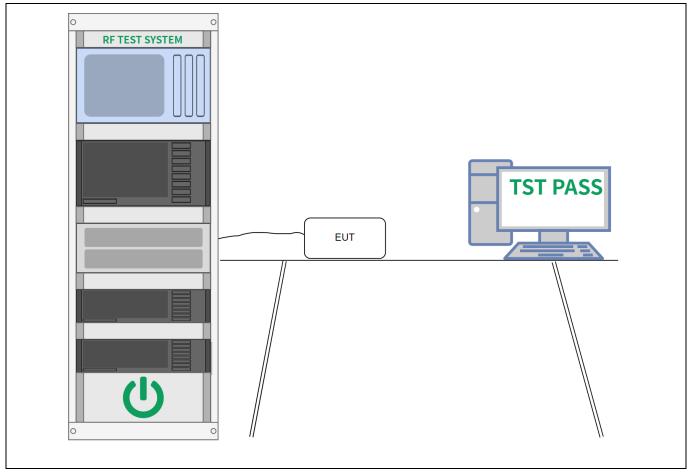
6.6 Emissions in non-restricted frequency bands

	<u> </u>
Test Requirement:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	Conducted spurious emissions test methodology
Procedure:	Conducted spurious emissions shall be measured for the transmit frequency, per 5.5 and 5.6, and at the maximum transmit powers. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The instrument shall span 30 MHz to 10 times the operating frequency in GHz, with a resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector. The band 30 MHz to the highest frequency may be split into smaller spans, as long as the entire spectrum is covered.

6.6.1 E.U.T. Operation:

Operating Envir	Operating Environment:						
Temperature:	26 °C		Humidity:	57 %		Atmospheric Pressure:	101 kPa
Pre test mode:		Mode	e1, Mode2, I	Mode3			
Final test mode	:	Mode	e1, Mode2, I	Mode3			

6.6.2 Test Setup Diagram:



6.6.3 Test Data:

Please Refer to Appendix for Details.



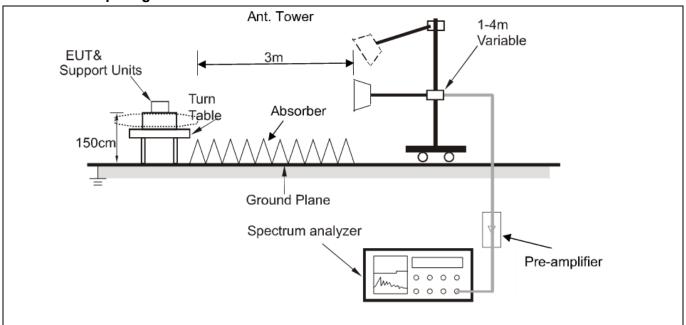
6.7 Band edge emissions (Radiated)

Test Requirement:		nissions which fall in the rest comply with the radiated em 5(c)).`					
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
	88-216	150 **	3				
	216-960	200 **	3				
	Above 960	500	3				
	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.						
Test Method:	Radiated emissions tes						
Procedure:	ANSI C63.10-2013 sed						

6.7.1 E.U.T. Operation:

Operating Envi	ronment:									
Temperature:	25 °C		Humidity:	50 %	Atmospheric Pressure:	101 kPa				
Pre test mode:	Pre test mode:			Mode1, Mode2, Mode3						
Final test mode) :		All of the listed pre-test mode were tested, only the data of the worst mode (Mode3) is recorded in the report							
Note:		All of recor		ns are attenua	ted 20dB below the limit, s	so does not				

6.7.2 Test Setup Diagram:





6.7.3 Test Data:

		MHz	dBuV	dB	dBuV/m	dBuV/m dB	Detector
1		2310.000	48.06	-8.08	39.98	74.00 -34.02	peak
2		2310.000	37.53	-8.08	29.45	54.00 -24.55	AVG
3	*	2390.000	66.24	-7.71	58.53	74.00 -15.47	peak
4		2390.000	40.88	-7.71	33.17	54.00 -20.83	AVG

	MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1	2310.000	47.32	-8.08	39.24	74.00	-34.76	peak
2	2310.000	37.25	-8.08	29.17	54.00	-24.83	AVG
3	2390.000	57.81	-7.71	50.10	74.00	-23.90	peak
4 *	2390.000	38.46	-7.71	30.75	54.00	-23.25	AVG



		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1	* 2	2483.500	78.01	-7.24	70.77	74.00	-3.23	peak
2	2	2483.500	51.03	-7.24	43.79	54.00	-10.21	AVG
3	2	2500.000	62.58	-7.17	55.41	74.00	-18.59	peak
4	2	2500.000	39.75	-7.17	32.58	54.00	-21.42	AVG

No.	М	k. Fre	Readin q. Level			Limit	Over	
		MH:	z dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1	*	2483.50	00 70.98	-7.24	63.74	74.00	-10.26	peak
2		2483.50	00 46.12	-7.24	38.88	54.00	-15.12	AVG
3		2500.00	00 57.76	-7.17	50.59	74.00	-23.41	peak
4		2500.00	00 38.20	-7.17	31.03	54.00	-22.97	AVG



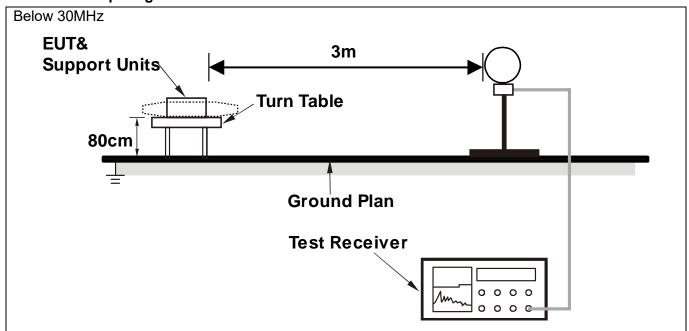
6.8 Emissions in restricted frequency bands (below 1GHz)

Test Requirement:	I	ssions which fall in the restrictomply with the radiated emistration).`	-
Test Limit:	Frequency (MHz)	Field strength	Measuremen
		(microvolts/meter)	t distance
			(meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	intentional radiators ope frequency bands 54-72	paragraph (g), fundamental rating under this section sha MHz, 76-88 MHz, 174-216 M in these frequency bands is l	ll not be located in the lHz or 470-806 MHz.
	33		
Test Method:	Radiated emissions test	S	
Procedure:	ANSI C63.10-2013 secti	on 6.6.4	

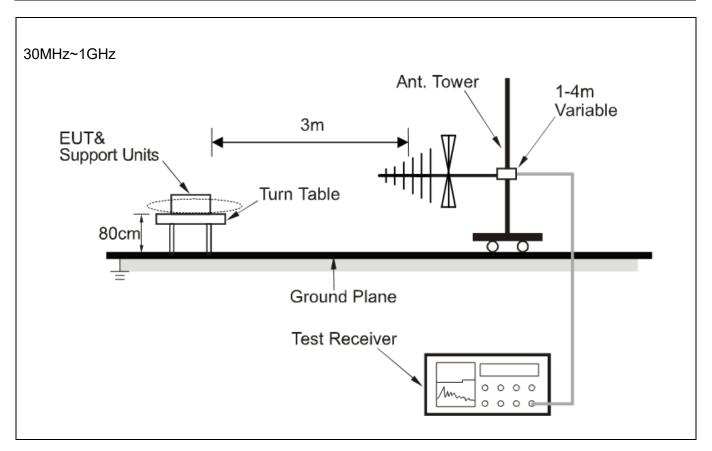
6.8.1 E.U.T. Operation:

Operating Envi	ronment:						
Temperature:	25 °C		Humidity:	50 %	Atmospheric Pressure:	101 kPa	
Pre test mode:	t mode: Mode1, Mode2, Mode3						
Final test mode	e:	All of the listed pre-test mode were tested, only the data of the worst mode (Mode3) is recorded in the report					
Note:		belov All m resul	w the limits a lodes of ope its are repor	are not reported ration of the El ted.	sions which are attenuated. UT were investigated, and below 30MHz within 20d	only the worst-case	

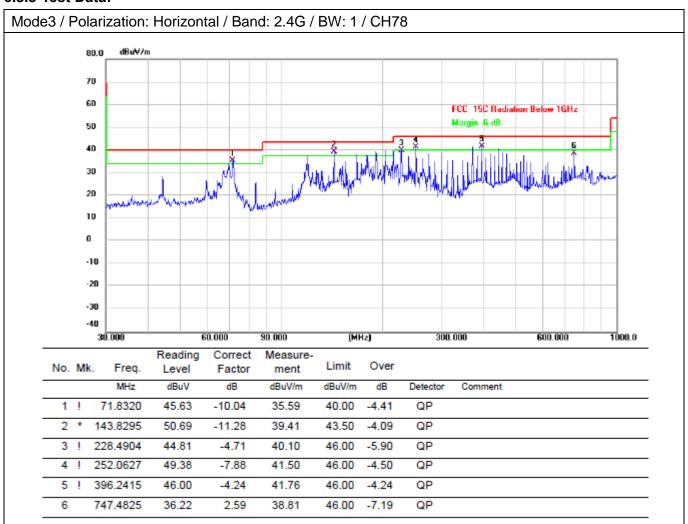
6.8.2 Test Setup Diagram:







6.8.3 Test Data:



4

5

6

228.4904

372.0045

39.16

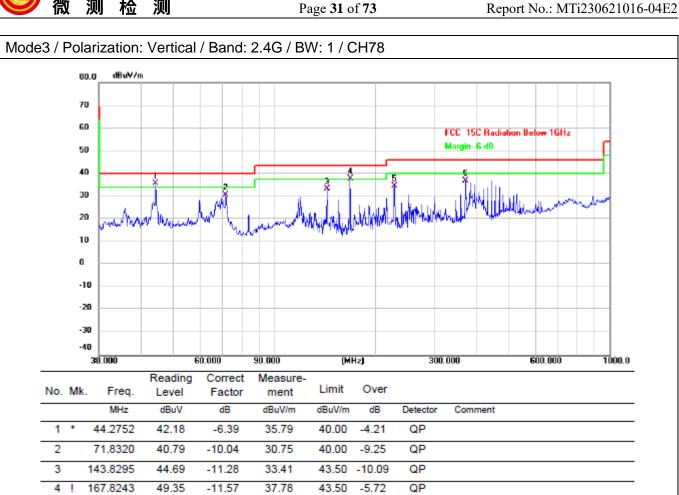
44.04

-4.71

-6.95

34.45

37.09



46.00 -11.55

-8.91

46.00

QΡ

QP



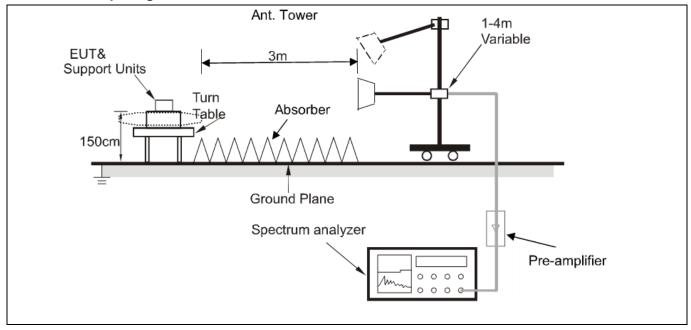
6.9 Emissions in restricted frequency bands (above 1GHz)

Test Requirement:		nissions which fall in the rest comply with the radiated em $\delta(c)$.	•
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	intentional radiators op frequency bands 54-72	n paragraph (g), fundamenta erating under this section sh MHz, 76-88 MHz, 174-216 hin these frequency bands is g.,	all not be located in the MHz or 470-806 MHz.
	§§ 15.231 and 15.241.		
Test Method:	Radiated emissions tes	ets	
Procedure:	ANSI C63.10-2013 sec	tion 6.6.4	

6.9.1 E.U.T. Operation:

Operating Envi	ironment:					
Temperature:	25 °C		Humidity:	50 %	Atmospheric Pressure:	101 kPa
Pre test mode:		Mode	e1, Mode2,	Mode3		
Final test mode	e:	Mode	e3			
Note:		whic All m	h are attenu	ated more thar eration of the E	o 25GHz, the amplitude on 20 dB below the limits and UT were investigated, and	e not reported.

6.9.2 Test Setup Diagram:





6.9.3 Test Data:

		MHz	dBuV	dB	dBuV/m	dBuV/m dB	Detector
1	4	4804.000	49.51	0.74	50.25	74.00 -23.75	peak
2	* 4	4804.000	43.82	0.74	44.56	54.00 -9.44	AVG
3	7	7206.000	40.44	6.02	46.46	74.00 -27.54	peak
4	7	7206.000	34.14	6.02	40.16	54.00 -13.84	AVG
5	ç	9608.000	40.53	5.88	46.41	74.00 -27.59	peak
6	ć	9608.000	34.41	5.88	40.29	54.00 -13.71	AVG



1	4804.000	44.17	0.74	44.91	74.00 -29.09	peak
	4604.000	44.17	0.74	44.31	74.00 -23.03	peak
2	4804.000	38.82	0.74	39.56	54.00 -14.44	AVG
3	7206.000	39.92	6.02	45.94	74.00 -28.06	peak
4	7206.000	33.36	6.02	39.38	54.00 -14.62	AVG
5	9608.000	41.12	5.88	47.00	74.00 -27.00	peak
6	* 9608.000	35.03	5.88	40.91	54.00 -13.09	AVG



1 4882.000 47.37 1.05 48.42 74.00 -25.58 2 * 4882.000 41.64 1.05 42.69 54.00 -11.31	peak
2 * 4882.000 41.64 1.05 42.69 54.00 -11.31	
	AVG
3 7323.000 39.74 5.94 45.68 74.00 -28.32	peak
4 7323.000 33.34 5.94 39.28 54.00 -14.72	AVG
5 9764.000 40.90 6.55 47.45 74.00 -26.55	peak
6 9764.000 34.70 6.55 41.25 54.00 -12.75	AVG



-1	4882.000	44.37	dB 1.05	45.42	74.00 20.50	nook
<u>'</u>	4002.000	44.37	1.05	45.42	74.00 -28.58	peak
2	4882.000	38.59	1.05	39.64	54.00 -14.36	AVG
3	7323.000	39.93	5.94	45.87	74.00 -28.13	peak
4	7323.000	33.39	5.94	39.33	54.00 -14.67	AVG
5	9764.000	41.24	6.55	47.79	74.00 -26.21	peak
6	* 9764.000	35.03	6.55	41.58	54.00 -12.42	AVG



	MHz	dBuV	dB	dBuV/m	dBuV/m dB	Detector
1	4960.000	47.22	1.50	48.72	74.00 -25.28	peak
2 *	4960.000	41.24	1.50	42.74	54.00 -11.26	AVG
3	7440.000	39.85	5.61	45.46	74.00 -28.54	peak
4	7440.000	33.92	5.61	39.53	54.00 -14.47	AVG
5	9920.000	40.55	6.10	46.65	74.00 -27.35	peak
6	9920.000	34.05	6.10	40.15	54.00 -13.85	AVG



1 4960.000 44.87 1.50 46.37 74.00 -27.63 peak 2 * 4960.000 38.86 1.50 40.36 54.00 -13.64 AVG 3 7440.000 39.82 5.61 45.43 74.00 -28.57 peak 4 7440.000 33.59 5.61 39.20 54.00 -14.80 AVG 5 9920.000 40.10 6.10 46.20 74.00 -27.80 peak 6 9920.000 33.97 6.10 40.07 54.00 -13.93 AVG		MHz	dBuV	dB	dBuV/m	dBuV/m dB	Detector
3 7440.000 39.82 5.61 45.43 74.00 -28.57 peak 4 7440.000 33.59 5.61 39.20 54.00 -14.80 AVG 5 9920.000 40.10 6.10 46.20 74.00 -27.80 peak	1	4960.000	44.87	1.50	46.37	74.00 -27.63	peak
4 7440.000 33.59 5.61 39.20 54.00 -14.80 AVG 5 9920.000 40.10 6.10 46.20 74.00 -27.80 peak	2 *	4960.000	38.86	1.50	40.36	54.00 -13.64	AVG
5 9920.000 40.10 6.10 46.20 74.00 -27.80 peak	3	7440.000	39.82	5.61	45.43	74.00 -28.57	peak
part of the second of the seco	4	7440.000	33.59	5.61	39.20	54.00 -14.80	AVG
6 9920.000 33.97 6.10 40.07 54.00 -13.93 AVG	5	9920.000	40.10	6.10	46.20	74.00 -27.80	peak
	6	9920.000	33.97	6.10	40.07	54.00 -13.93	AVG



Photographs of the test setup

Refer to Appendix - Test Setup Photos.



Photographs of the EUT

Refer to Appendix - EUT Photos



Appendix



Appendix A: 20dB Emission Bandwidth

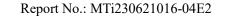
Test Result

Test Mode	Antenna	Frequency [MHz]	20db EBW [MHz]
		2402	1.032
DH5	Ant1	2441	0.987
		2480	0.963
2DH5		2402	1.377
	Ant1	2441	1.371
		2480	1.365
3DH5		2402	1.347
	Ant1	2441	1.353
		2480	1.356

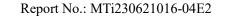


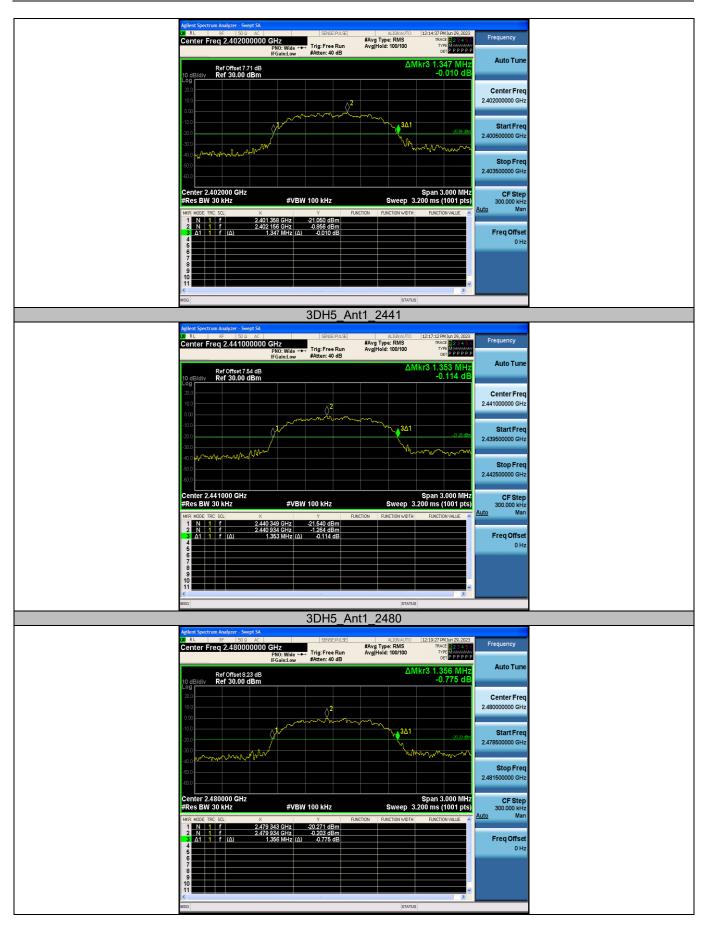
Test Graphs











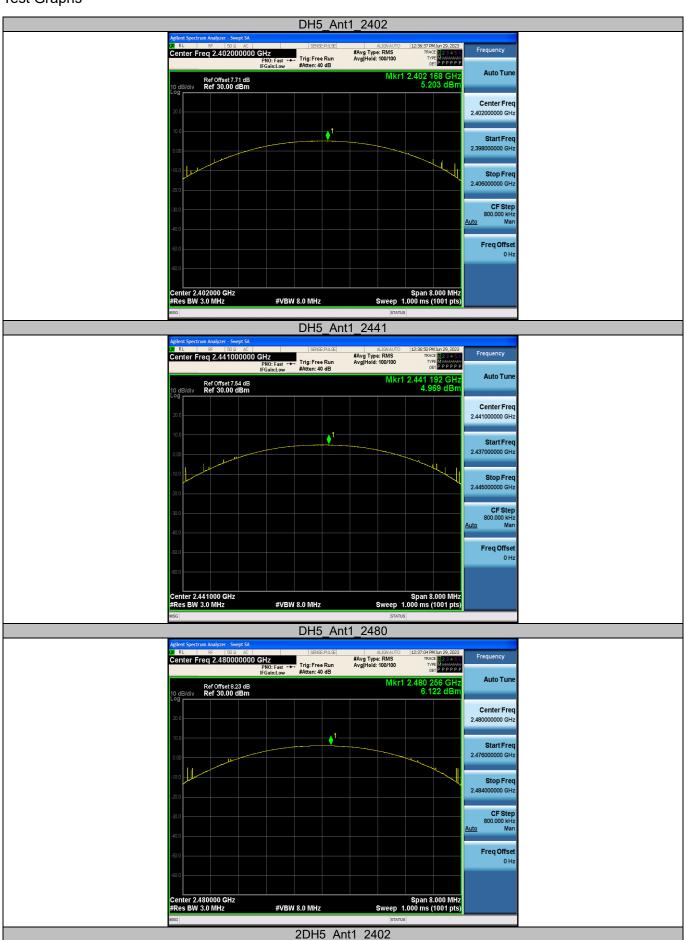


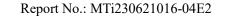
Appendix B: Maximum conducted output power

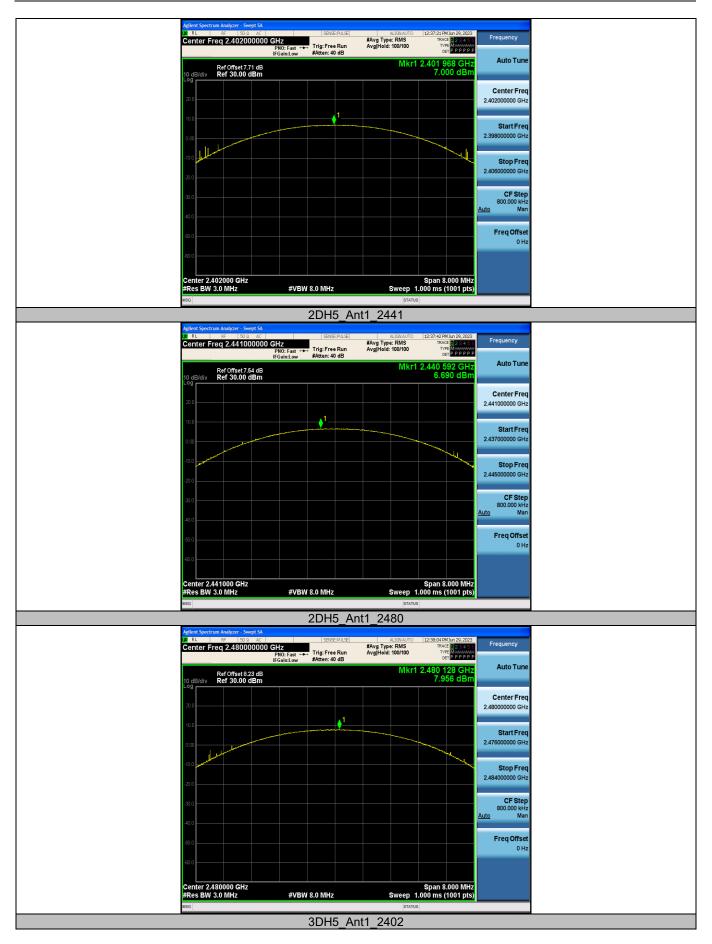
Test Result Peak

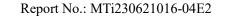
Test Mode	Antenna	Frequency [MHz]	Conducted Peak Power [dBm]	Limit [dBm]	Verdict
DH5	Ant1	2402	5.2	≤20.97	PASS
		2441	4.97	≤20.97	PASS
		2480	6.12	≤20.97	PASS
2DH5	Ant1	2402	7	≤20.97	PASS
		2441	6.69	≤20.97	PASS
		2480	7.96	≤20.97	PASS
3DH5	Ant1	2402	7.46	≤20.97	PASS
		2441	7.17	≤20.97	PASS
		2480	8.32	≤20.97	PASS

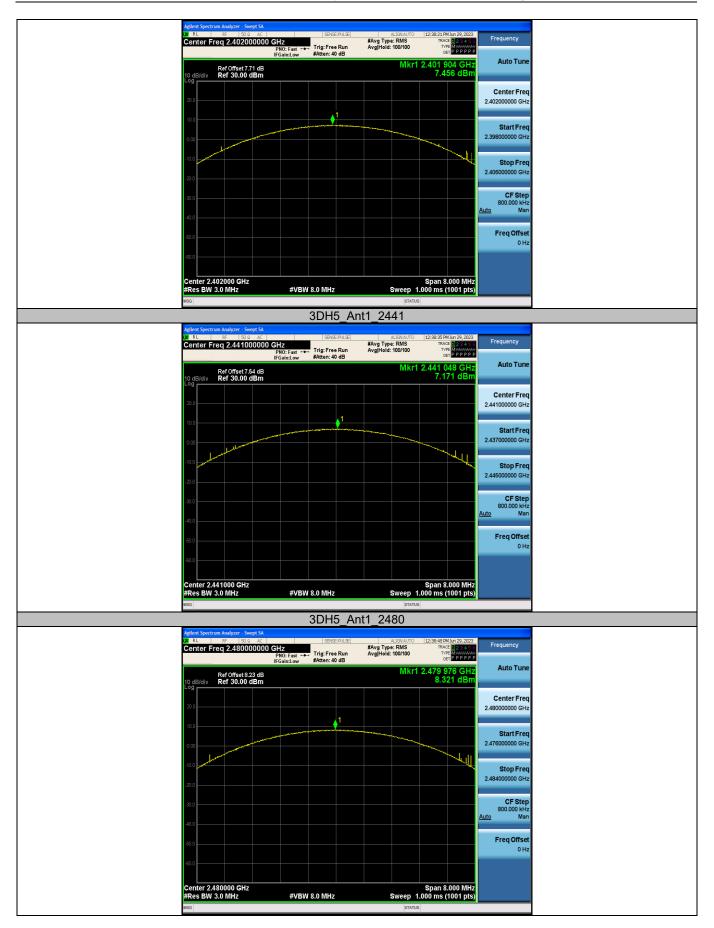
Test Graphs













Appendix C: Carrier frequency separation

Test Result

Test Mode	Antenna	Frequency [MHz]	Result [MHz]	Limit [MHz]	Verdict
DH5	Ant1	Нор	1	≥0.688	PASS
2DH5	Ant1	Нор	1.004	≥0.918	PASS
3DH5	Ant1	Нор	1.002	≥0.904	PASS